國立交通大學 電子物理研究所 碩士論文

氮化銦奈米點之拉曼光譜和 X-ray 繞射和微 螢光光譜應力分析

Strain analysis of InN nano-dots by Raman and X-ray and µ–PL measurements

研 究 生:羅士傑

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